

SiC Power MOSFET

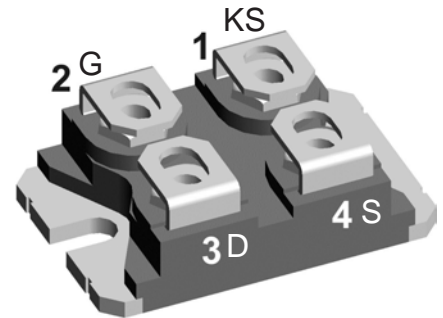
preliminary

$$I_{D25} = 90 \text{ A}$$

$$V_{DSS} = 1700 \text{ V}$$

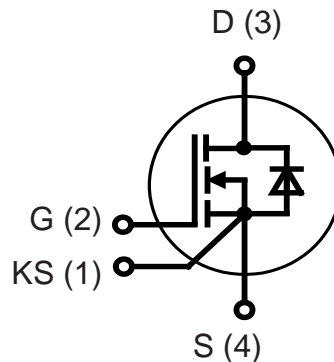
$$R_{DS(on) \text{ max}} = 35 \text{ m}\Omega$$

Kelvin Source gate connection

Part number
 IXFN90N170SK


Backside: isolated

UL pending


Features / Advantages:

- High speed switching with low capacitances
- High blocking voltage with low $R_{DS(on)}$
- Easy to parallel and simple to drive
- Resistant to latch-up
- Real Kelvin source connection

Applications:

- Solar inverters
- High voltage DC/DC converters
- Motor drives
- Switch mode power supplies
- UPS
- Battery chargers
- Induction heating

Package: SOT-227B (minibloc)

- Isolation Voltage: 3000 V~
- Industry standard outline
- RoHS compliant
- Epoxy meets UL 94V-0
- Base plate with Aluminium nitride isolation
- Advanced power cycling

Terms & Conditions of usage

The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application- and assembly notes must be considered. Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact your local sales office.

Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact your local sales office.

Should you intend to use the product in aviation, in health or life endangering or life support applications, please notify. For any such application we urgently recommend

- to perform joint risk and quality assessments;

- the conclusion of quality agreements;

- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures.



preliminary

| MOSFET | | | | Ratings | | | |
|----------------|-----------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------|------|-----|-----|
| Symbol | Definitions | Conditions | min. | typ. | max. | | |
| $V_{(BR)DSS}$ | drain source breakdown voltage | $I_D = 200 \mu A$ $T_{VJ} = 25^\circ C$ | 1700 | | | V | |
| $V_{GS(max)}$ | max transient gate source voltage | | -10 | | +25 | V | |
| V_{GS} | continous gate source voltage | recommended operational value | -5 | | +20 | V | |
| I_{D25} | drain current | $V_{GS} = 20 V$ | | | 90 | A | |
| I_{D80} | | | $T_C = 25^\circ C$ | | | 67 | A |
| I_{D100} | | | $T_C = 80^\circ C$ | | | 56 | A |
| R_{DSon} | static drain source on resistance | $I_D = 100 A; V_{GS} = 20 V$ | $T_{VJ} = 25^\circ C$ | 23 | 35 | mΩ | |
| | | | $T_{VJ} = 150^\circ C$ | 45 | | mΩ | |
| $V_{GS(th)}$ | gate threshold voltage | $I_D = 36 mA; V_{GS} = V_{DS}$ | $T_{VJ} = 25^\circ C$ | 2.0 | 2.4 | 4.0 | V |
| | | | $T_{VJ} = 150^\circ C$ | | 1.8 | | V |
| I_{DSS} | drain source leakage current | $V_{DS} = 1700 V; V_{GS} = 0 V$ | | 5 | 200 | μA | |
| I_{GSS} | gate source leakage current | $V_{DS} = 0 V; V_{GS} = 20 V$ | | | 1.2 | μA | |
| R_G | internal gate resistance | $f = 1 MHz, V_{AC} = 25 mV, ESR \text{ of } C_{ISS}$ | | 1.9 | | Ω | |
| C_{iss} | input capacitance | $V_{DS} = 1000 V; V_{GS} = 0 V; f = 1 MHz \quad T_{VJ} = 25^\circ C$ | | 7340 | | pF | |
| C_{oss} | output capacitance | | | 342 | | pF | |
| C_{rss} | reverse transfer (Miller) capacitance | | | 13.5 | | pF | |
| Q_g | total gate charge | $V_{DS} = 1200 V; I_D = 100A; V_{GS} = -5/20 V$ $T_{VJ} = 25^\circ C$ | | 376 | | nC | |
| Q_{gs} | gate source charge | | | 88 | | nC | |
| Q_{gd} | gate drain (Miller) charge | | | 114 | | nC | |
| $t_{d(on)}$ | turn-on delay time | Inductive switching $V_{DS} = 1200 V; I_D = 70 A \quad T_{VJ} = 25^\circ C$ $V_{GS} = -5 / 20 V; R_G = 2.5 \Omega$ (external) Free wheeling diode: Body diode @ $V_{GS} = -5 V$ | | 34 | | ns | |
| t_r | current rise time | | | 13 | | ns | |
| $t_{d(off)}$ | turn-off delay time | | | 75 | | ns | |
| t_f | current fall time | | | 27 | | ns | |
| E_{on} | turn-on energy per pulse | | | 2.58 | | mJ | |
| E_{off} | turn-off energy per pulse | | | 0.77 | | mJ | |
| $E_{rec(off)}$ | reverse recovery losses at turn-off | | | 0.66 | | mJ | |
| $t_{d(on)}$ | turn-on delay time | | Inductive switching $V_{DS} = 1200 V; I_D = 70 A \quad T_{VJ} = 150^\circ C$ $V_{GS} = -5 / 20 V; R_G = 2.5 \Omega$ (external) Free wheeling diode: Body diode @ $V_{GS} = -5 V$ | | 36 | | ns |
| t_r | current rise time | | | | 13 | | ns |
| $t_{d(off)}$ | turn-off delay time | | | | 105 | | ns |
| t_f | current fall time | | | 33 | | ns | |
| E_{on} | turn-on energy per pulse | | | 4.90 | | mJ | |
| E_{off} | turn-off energy per pulse | | | 1.05 | | mJ | |
| $E_{rec(off)}$ | reverse recovery losses at turn-off | | | 1.89 | | mJ | |
| R_{thJC} | thermal resistance junction to case | | | | 0.22 | | K/W |
| R_{thJH} | thermal resistance junction to heatsink | with heatsink compound; IXYS test setup | | | 0.30 | | K/W |

| Source-Drain Diode | | | | Ratings | | |
|--------------------|-------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------|------|---------|------|------|
| Symbol | Definitions | Conditions | min. | typ. | max. | |
| V_{SD} | forward voltage drop | $I_F = 70 A; V_{GS} = -5 V$ $T_{VJ} = 25^\circ C$ $T_{VJ} = 150^\circ C$ | | 4.3 | | V |
| t_{rr} | reverse recovery time | $V_{GS} = -5 V; I_F = 70 A; V_R = 1200 V \quad T_{VJ} = 25^\circ C$ Mosfet gate drive: $V_{GS} = -5 / 20 V; R_G = 2.5 \Omega$ | | 24 | | ns |
| Q_{RM} | reverse recovery charge (intrinsic diode) | | | 1.4 | | μC |
| I_{RM} | max. reverse recovery current | | | 92 | | A |
| dl_f/dt | current slew rate | | | 7300 | | A/μs |
| t_{rr} | reverse recovery time | $V_{GS} = -5 V; I_F = 70 A; V_R = 1200 V \quad T_{VJ} = 150^\circ C$ Mosfet gate drive: $V_{GS} = -5 / 20 V; R_G = 2.5 \Omega$ | | 38 | | ns |
| Q_{RM} | reverse recovery charge (intrinsic diode) | | | 3.9 | | μC |
| I_{RM} | max. reverse recovery current | | | 170 | | A |
| dl_f/dt | current slew rate | | | 6350 | | A/μs |

Note:

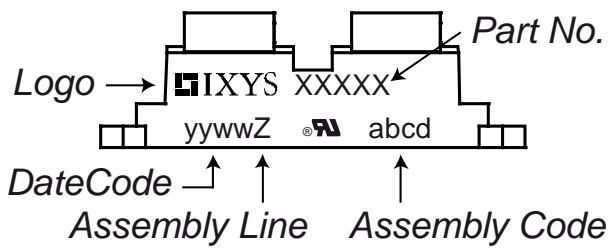
When using SiC Body Diode the maximum recommended $V_{GS} = -5V$



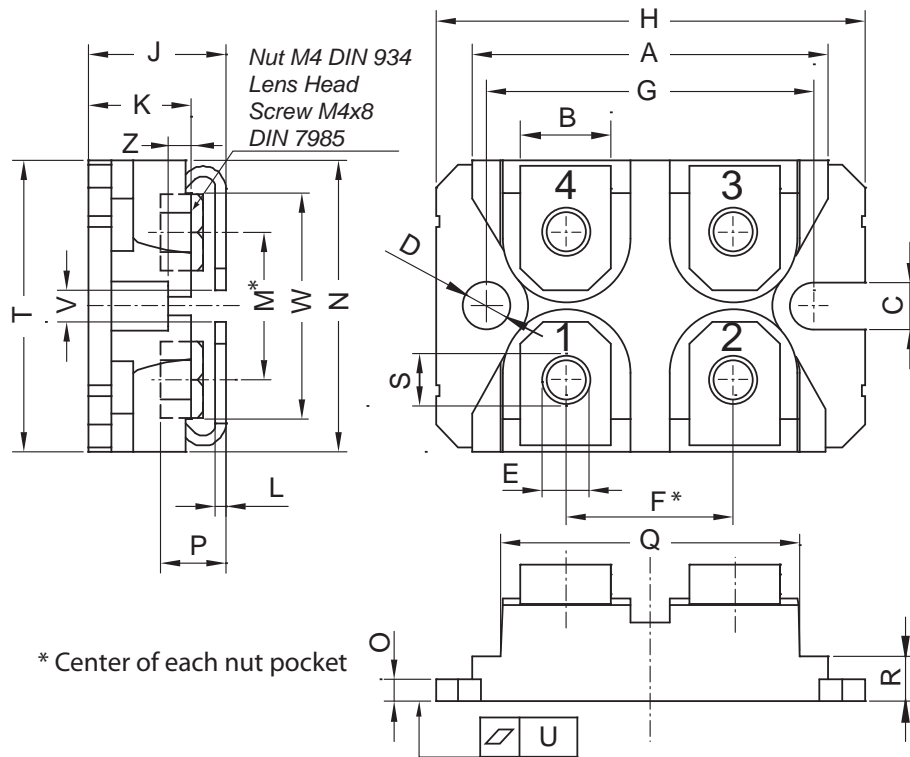
Package SOT-227B (minibloc)

| Symbol | Definitions | Conditions | Ratings | | | Unit |
|-----------------|--------------------------------------------------------------|-------------------------------------------------|------------|------|------|------|
| | | | min. | typ. | max. | |
| I_{RMS} | RMS current | per terminal | | | | A |
| T_{stg} | storage temperature | | -40 | | 150 | °C |
| T_{op} | operation temperature | | -40 | | 150 | °C |
| T_{VJ} | virtual junction temperature | | -40 | | 150 | °C |
| Weight | | | | 30 | | g |
| M_D | mounting torque | | 1.1 | | 1.5 | Nm |
| M_T | terminal torque | | 1.1 | | 1.5 | Nm |
| $d_{Spp/App}$ | creepage distance on surface striking distance through air | terminal to backside | 10.5 / 3.2 | | | mm |
| $d_{Spbl/Appb}$ | | terminal to terminal | 8.6 / 6.8 | | | mm |
| V_{ISOL} | isolation voltage | $I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz},$ | | | | V |
| | | $t = 1 \text{ sec.}$ | 3000 | | | V |
| | | $t = 1 \text{ minute}$ | 2500 | | | V |

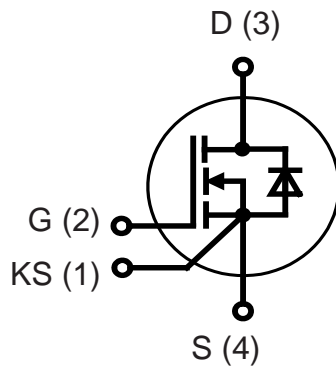
Product Marking



| Ordering | Part Name | Marking on Product | Delivering Mode | Base Qty | Ordering Code |
|----------|--------------|--------------------|-----------------|----------|---------------|
| Standard | IXFN90N170SK | IXFN90N170SK | Tube | 10 | 519108 |

Outlines SOT-227B (minibloc)


| Dim. | Millimeter | | Inches | |
|------|------------|-------|--------|-------|
| | min | max | min | max |
| A | 31.50 | 31.88 | 1.240 | 1.255 |
| B | 7.80 | 8.20 | 0.307 | 0.323 |
| C | 4.09 | 4.29 | 0.161 | 0.169 |
| D | 4.09 | 4.29 | 0.161 | 0.169 |
| E | 4.09 | 4.29 | 0.161 | 0.169 |
| F | 14.91 | 15.11 | 0.587 | 0.595 |
| G | 30.12 | 30.30 | 1.186 | 1.193 |
| H | 37.80 | 38.23 | 1.488 | 1.505 |
| J | 11.68 | 12.22 | 0.460 | 0.481 |
| K | 8.92 | 9.60 | 0.351 | 0.378 |
| L | 0.74 | 0.84 | 0.029 | 0.033 |
| M | 12.50 | 13.10 | 0.492 | 0.516 |
| N | 25.15 | 25.42 | 0.990 | 1.001 |
| O | 1.95 | 2.13 | 0.077 | 0.084 |
| P | 4.95 | 6.20 | 0.195 | 0.244 |
| Q | 26.54 | 26.90 | 1.045 | 1.059 |
| R | 3.94 | 4.42 | 0.155 | 0.167 |
| S | 4.55 | 4.85 | 0.179 | 0.191 |
| T | 24.59 | 25.25 | 0.968 | 0.994 |
| U | -0.05 | 0.10 | -0.002 | 0.004 |
| V | 3.20 | 5.50 | 0.126 | 0.217 |
| W | 19.81 | 21.08 | 0.780 | 0.830 |
| Z | 2.50 | 2.70 | 0.098 | 0.106 |



Curves

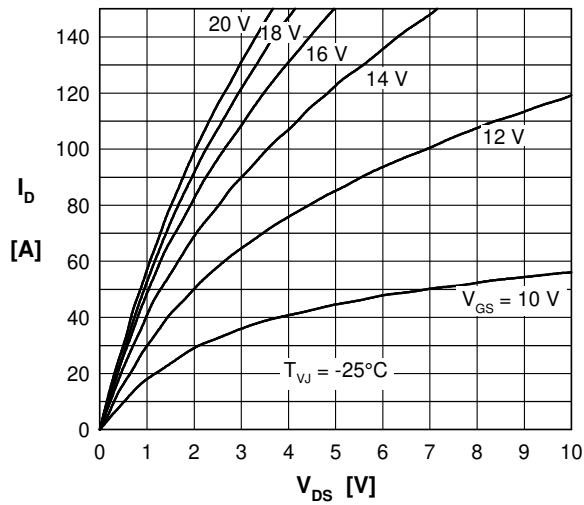


Fig. 1 Typical output characteristics (-25°C)

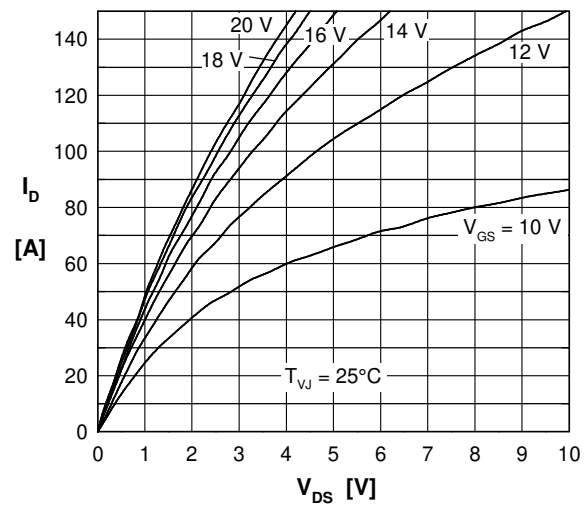


Fig. 2 Typical output characteristics (25°C)

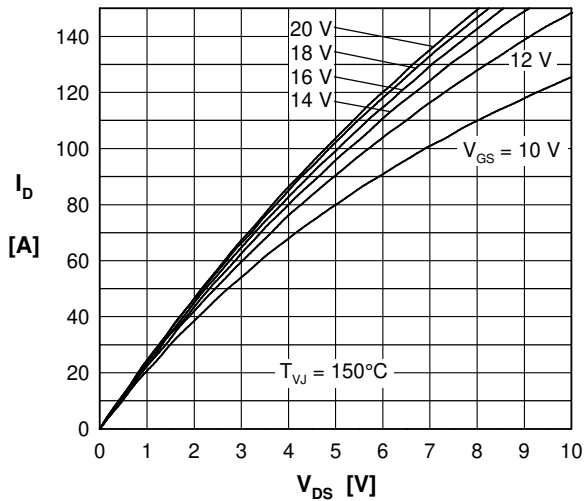


Fig. 3 Typical output characteristics (150°C)

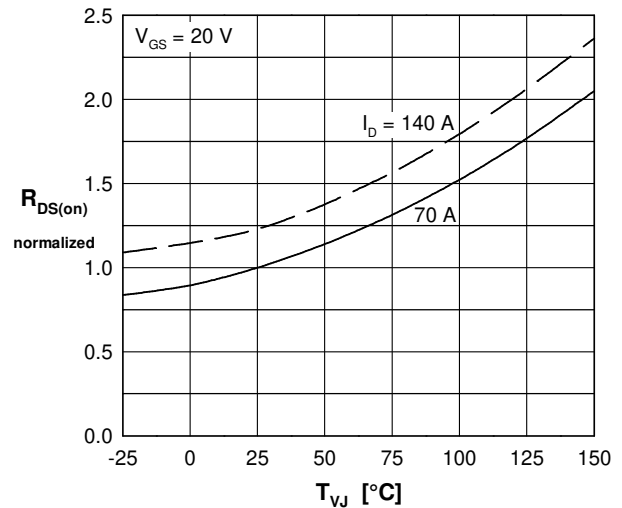


Fig. 4 $R_{DS(on)}$ normalized vs. junction temperature T_{VJ}

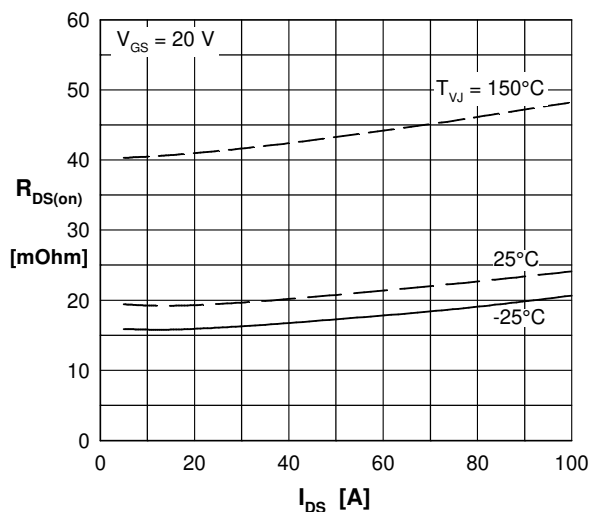


Fig. 5 $R_{DS(on)}$ versus drain current

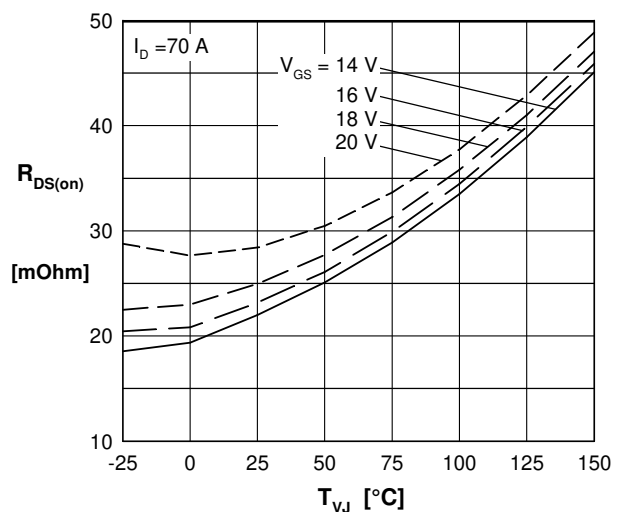


Fig. 6 $R_{DS(on)}$ versus junction temperature T_{VJ}

Curves

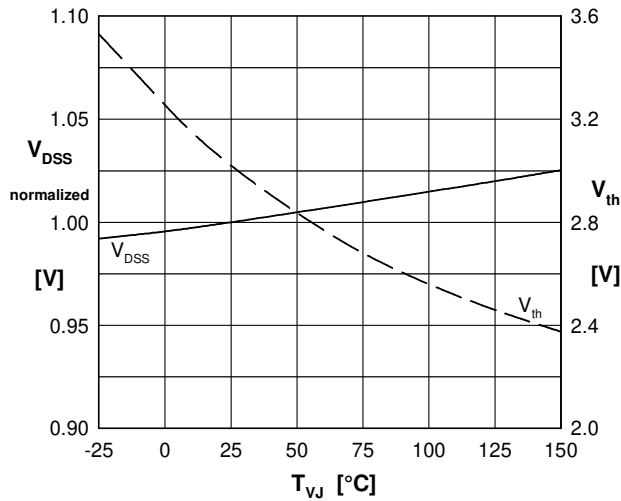


Fig. 7 Threshold voltage V_{TH} and normalized V_{DSS} versus junction temperature T_{VJ}

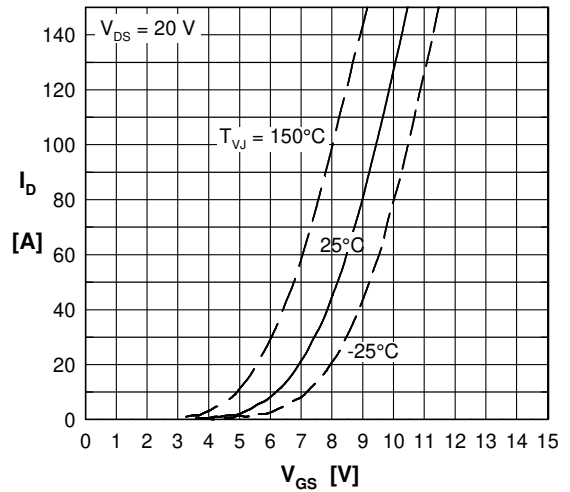


Fig. 8 Typical transfer characteristics

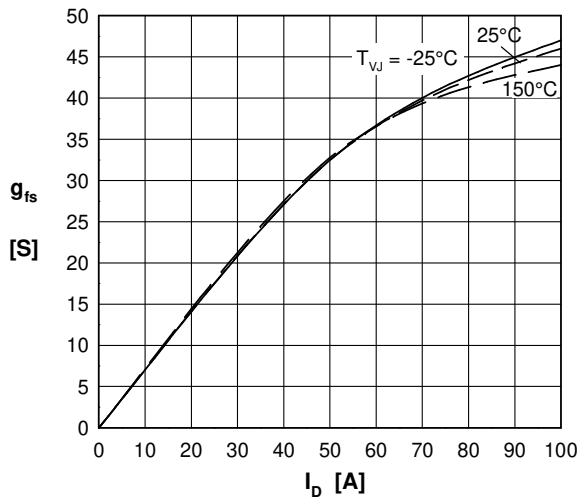


Fig. 9 Typical forward transconductance

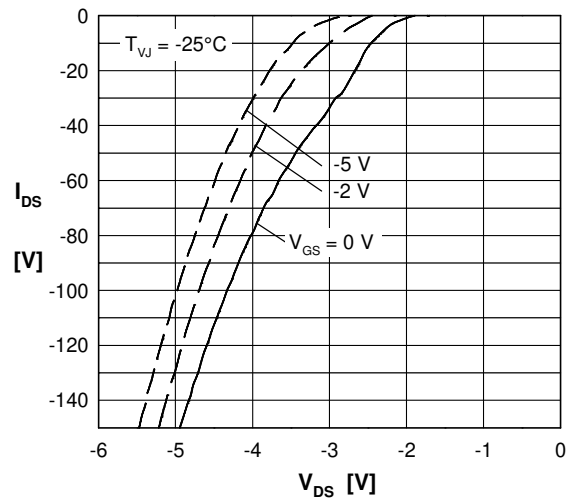


Fig. 10 Forward voltage drop of intrinsic diode versus V_{DS} measured at -25°C

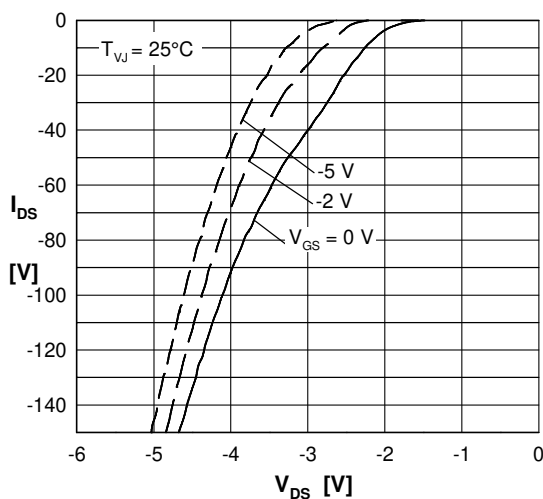


Fig. 11 Forward voltage drop of intrinsic diode versus V_{DS} measured at 25°C

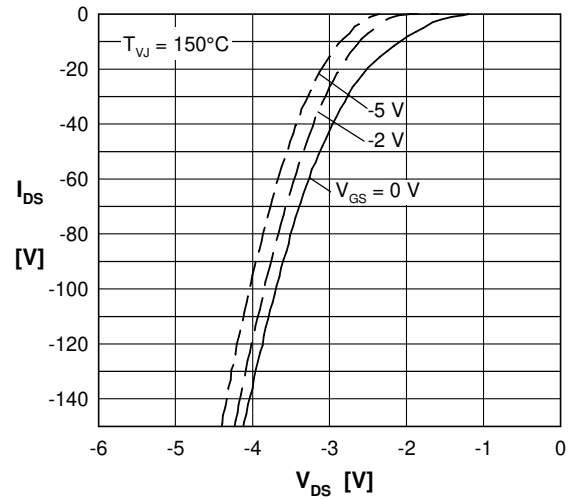
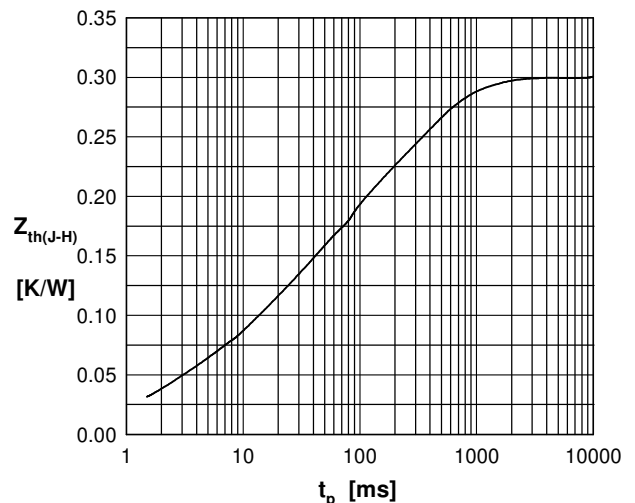
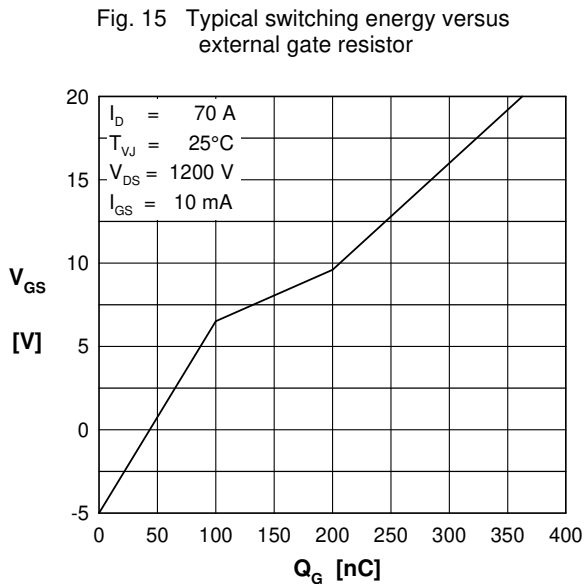
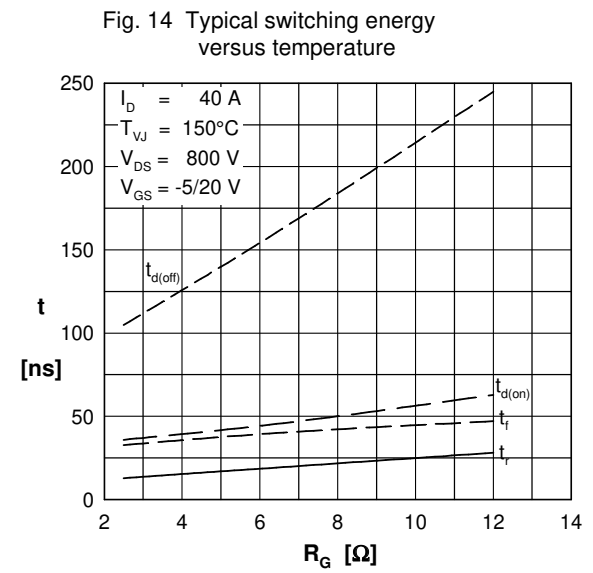
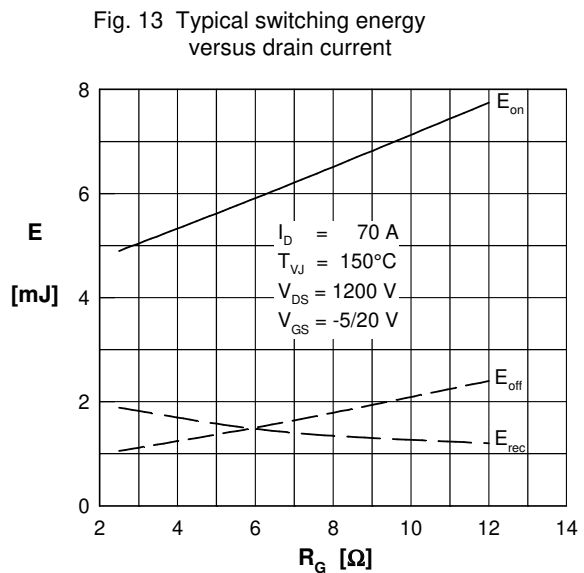
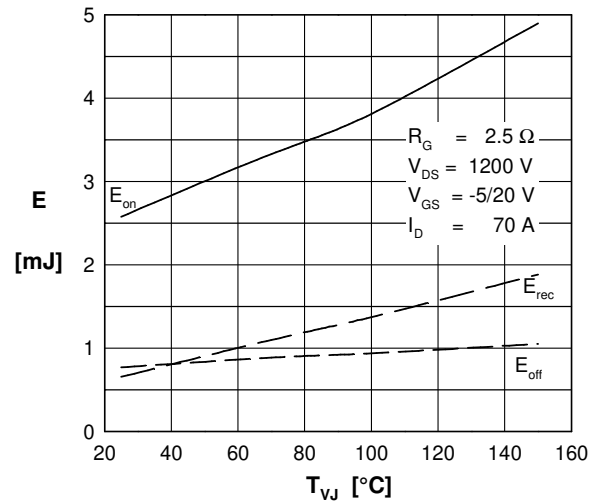
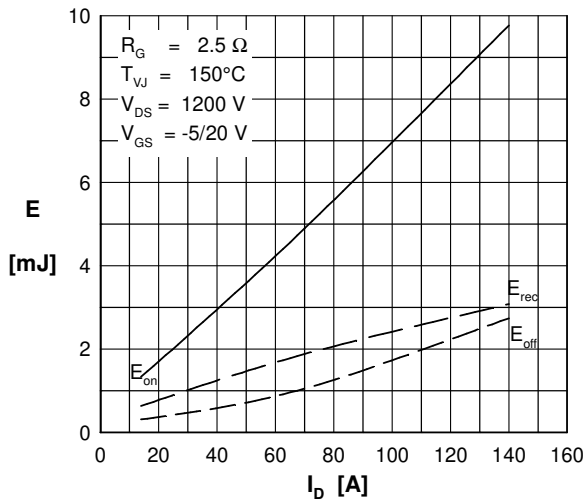


Fig. 12 Forward voltage drop of intrinsic diode versus V_{DS} measured at 150°C



Curves



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[DMN1006UCA6-7](#) [DMN16M9UCA6-7](#)